Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
08/977,591	NAKATA ET AL.	
Examiner	Art Unit	
Hai Tran	2611	

	SEAR	CHED	
Class	Subclass	Date	Examiner
725	37,74 78,80 14	5/25/05	HUT
348	734		
709	226		
455	3,04		
340	3.1	<b>V</b>	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST SEARCH	5/24/08	HV		
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